## **CLAIMS**

- 1. A maskless nano-ion-beam lithography (MNBL) system, comprising:
- a plasma generator which produces ions in a plasma generation region;
- a pattern generator positioned adjacent to the plasma generation region of the ion source for electrostatically producing a controlled pattern of micro-ion-beamlets;

a high voltage source connected between the pattern generator and workpiece for accelerating and focusing the micro-ion-beamlets extracted from the plasma generation region through the pattern generator to produce a demagnified final ion beam on the workpiece.

- 2. The MNBL system of Claim 7 wherein the plasma generator comprises a multicusp ion source.
- 3. The MNBL system of Claim 1 wherein the pattern generator comprises a two electrode blanking system.
- 4. The MNBL system of Claim 1 further comprising a low voltage source connected to the pattern generator for applying voltages to the pattern generator to control individual beamlets.
- 5. The MNBL system of Claim 1 wherein the pattern generator comprises a pair of spaced electrodes having a plurality of apertures therethrough, and a controllable